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PPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
10/707,824	01/15/2004	Long-Hui Lin	LKSP0029USA	1823
27765 75	7590 10/24/2005		EXAMINER	
NORTH AMERICA INTELLECTUAL PROPERTY CORPORATION			COLEMAN, WILLIAM D	
P.O. BOX 506 MERRIFIELD, VA 22116			ART UNIT	PAPER NUMBER
MERKITIELD,	VA 22110		2823	
			DATE MAILED: 10/24/200	5

Please find below and/or attached an Office communication concerning this application or proceeding.

•1		Ale
	Application No.	Applicant(s)
	10/707,824	LIN, LONG-HUI
Office Action Summary	Examiner	Art Unit
	W. David Coleman	2823
The MAILING DATE of this communication a Period for Reply	ppears on the cover sheet wi	th the correspondence address
A SHORTENED STATUTORY PERIOD FOR REPOWHICHEVER IS LONGER, FROM THE MAILING - Extensions of time may be available under the provisions of 37 CFR after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period. - Failure to reply within the set or extended period for reply will, by state Any reply received by the Office later than three months after the main earned patent term adjustment. See 37 CFR 1.704(b).	DATE OF THIS COMMUNION (1.136(a). In no event, however, may a root will apply and will expire SIX (6) MON ute, cause the application to become AE	CATION. eply be timely filed THS from the mailing date of this communication. BANDONED (35 U.S.C. § 133).
Status		
1) Responsive to communication(s) filed on 12	August 2005.	
2a) ☐ This action is FINAL. 2b) ☐ Th		
3) Since this application is in condition for allow	vance except for formal matt	
closed in accordance with the practice under Disposition of Claims	i Ex parte Quayle, 1935 C.D	. 11, 455 O.G. 215.
 4) Claim(s) 1-9 is/are pending in the application 4a) Of the above claim(s) is/are withdenset 5) Claim(s) is/are allowed. 6) Claim(s) 1-9 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and 	rawn from consideration.	
	voi election requirement.	
Application Papers OCT The specification is objected to by the Eveni	nor	
9) The specification is objected to by the Exami		hy the Examiner
Applicant may not request that any objection to the		
Replacement drawing sheet(s) including the corre	•	
11) The oath or declaration is objected to by the	•	· · · · · ·
Priority under 35 U.S.C. § 119		
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority docume 2. Certified copies of the priority docume 3. Copies of the certified copies of the priority docume application from the International Bure	nts have been received. Ints have been received in A Tiority documents have been	pplication No
* See the attached detailed Office action for a li	st of the certified copies not	received.
Attachment(s)		•
1) Notice of References Cited (PTO-892)	4) Interview S	Summary (PTO-413)
2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/0 Paper No(s)/Mail Date	<u> [77]</u>	s)/Mail Date nformal Patent Application (PTO-152)

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DETAILED ACTION

Response to Arguments

- 1. Applicant's arguments filed August 12, 2005 have been fully considered but they are not persuasive.
- 2. In response to applicant's argument that the references fail to show certain features of applicant's invention, it is noted that the features upon which applicant relies (i.e., second defect inspection (defect review) are not recited in the rejected claim(s). Although the claims are interpreted in light of the specification, limitations from the specification are not read into the claims. See *In re Van Geuns*, 988 F.2d 1181, 26 USPQ2d 1057 (Fed. Cir. 1993).

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

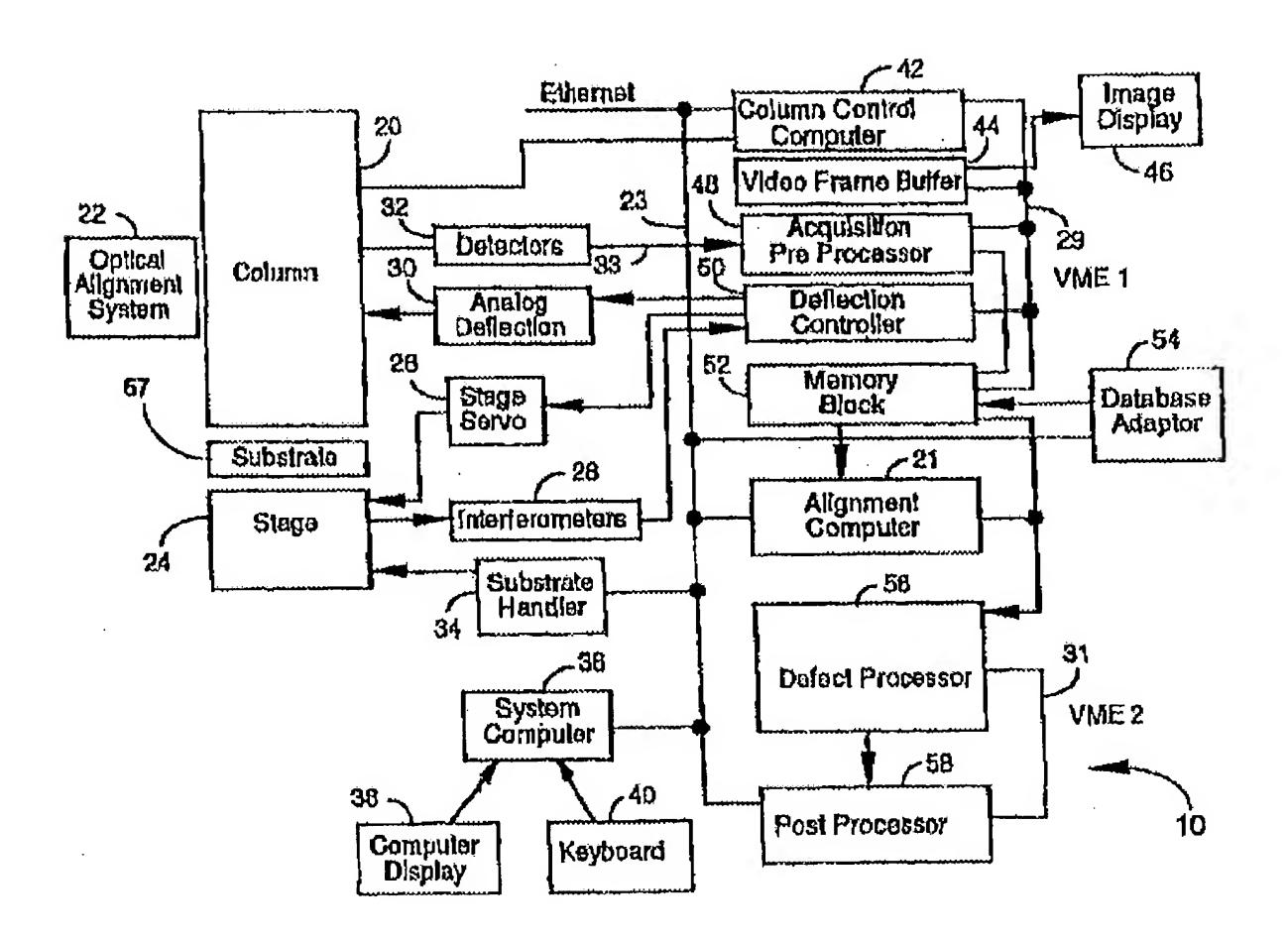
A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1-9 are rejected under 35 U.S.C. 102(b) as being anticipated by Satya et al., U.S. Patent 6,445,199 B1.

Satya discloses a semiconductor process as claimed. See FIGS. 1-35, where Satya teaches the following limitations.

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Pertaining to claim 1, <u>Satya</u> teaches a method of defect review comprising following steps:

providing a wafer with a plurality of defects;

performing a defect inspection to detect the defects; performing an automatic defect classification according to a database to separate the defects into a plurality of defect types; and performing a defect review;

wherein each defect type has different sampling ratios in the defect review according to its influence degree of process yield (see column 7, lines 14-48).

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4. Pertaining to claim 2, <u>Satya</u> teaches the method of claim 1 wherein the database comprises information about the plurality of defect types and defect information corresponding to each defect type (see FIG. 3).

- 5. Pertaining to claim 3, Satya teaches the method of claim 2 wherein the defect information comprises the influence degree of the process yield of each defect type.
- 6. Pertaining to claim 4, <u>Satya</u> teaches the method of claim 3 wherein the database separates the defect types into killer defects and non-killer defects according to the influence degree of the process yield (column 31, lines 3-14).
- 7. Pertaining to claim 5, Satya teaches the method of claim 4 wherein the sampling ratio of the killer defects in the defect review is larger than that of the non-killer defects (column 31, lines 25-51).
- 8. Pertaining to claim 6, <u>Satya</u> teaches the method of claim 3 wherein the database separates the defects into pre-layer defects and adding defects, and further separates the adding defects into killer defects and non-killer defects (see column 31).
- 9. Pertaining to claim 7, Satya teaches the method of claim 6 wherein the defect review focuses on the adding defects.

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10. Pertaining to claim 8. Satya teaches the method of claim 1 wherein after finishing the defect inspection, a judgment of cluster defects is performed and a defect review with a high sampling ratio is performed on the cluster defects if the cluster defects exist.

11. Pertaining to claim 9, <u>Satya</u> teaches the method of claim 1 wherein the database is updated according to the result of the defect review after finishing the defect review.

Conclusion

- 12. THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).
- 13. A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.
- 14. Any inquiry concerning this communication or earlier communications from the examiner should be directed to W. David Coleman whose telephone number is 571-272-1856. The examiner can normally be reached on Monday-Friday 9:00 AM 5:30 PM.

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- 15. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Olik Chaudhuri can be reached on 571-272-1855. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.
- 16. Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

W. David Coleman Primary Examiner Art Unit 2823

WDC